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TEST REPORT For FCC

Test Report No. : 2007020038

Date of Issue : March 16, 2007

FCC ID : U5MSPP-R200

Model/Type No. : SPP-u200vwxyz

Kind of Product : Thermal mobile printer

Applicant : BIXOLON Co., Ltd.

Applicant Address : A-5F, Digital Empire Bldg., 980-3 Yeongtong-Dong,

Yeongtong-Gu, Suwon, Gyeonggi Korea

Manufacturer : BIXOLON Co., Ltd.

Manufacturer Address : A-5F, Digital Empire Bldg., 980-3 Yeongtong-Dong,

Yeongtong-Gu, Suwon, Gyeonggi Korea

Contact Person : Chi young Ahn / Assitant Manager

Telephone : +82-31-218-5555

Received Date : Febarury 22, 2007

Test period : Start : Febarury 01, 2007 End : March 15, 2007

The test results presented in this report relate only to the object tested.

CTK Co., Ltd. is accredited by Korea Laboratory Accreditation Scheme (KOLAS) which signed the International Laboratory Accreditation Cooperation (ILAC) Mutual Recognition Arrangement (MRA) for the above test item(s) and test method(s).

Tested by

Reviewed by

Eun-Won, Lee Test Engineer

Date: March 16, 2007

Young-Joon, Park Technical Manager Date: March 16, 2007

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REPORT REVISION HISTORY

Date	Revision	Page No
March 16, 2007	Issued (2007020038)	All

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1.0 General Product Description

Equipment model name : SPP-u200vwxyz

Serial number : Prototype

EUT condition : Pre-production, not damaged

Antenna type : Chip antenna Gain 1.77dBi

Frequency Range : 2402 ~ 2480 MHz

RF output power Range : -6 dBm ~ +4 dBm (Class 2)

RF power : 2.83 dBm - Conducted

Number of channels : 79

Channel Spacing : 1 MHz

Channel Access Protocol : Frequency Hopping

Type of Modulation : GFSK

Power Source : Internal Lithium-ion Battery(rechargeable battery) - 3.7 Vdc

1.1 Tested Frequency

	LOW	MID	HIGH
Frequency (MHz)	2402	2441	2480

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1.2 Model Differences

In the model name of SPP-u200vwxyz

- u: means available paper type (<ex>label paper, receipt paper), It can be A-Z or blank.
- v: means communication interface, It can be A-Z or blank.
- w: means paper cut type, (ex. manual, cutter, peeler) It can be A-Z or blank.
- x: means product color, It can be A-Z or blank.
- yz: means additional accessory or optional function. It can be A-Z or blank.

1.3 Device Modifications

The following modifications were necessary for compliance:

Not applicable

1.4 Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Personal Computer	Samsung Electronics Co,. Ltd.	DM-V60	493J96BLB00311Y	DoC
LCD Monitor	TIANJIN SAMSUNG ELCTRONICS DISPLAY	GH17US	N372HVEX225526	DoC
Adaptor	Anam Instruments (Shen Zhen) Co., Ltd.	AP04214-UV	0312103885AC	-
Keyboard (PS/2 type)	Hewlett-Packard Company	5219	BN5017686	DoC
Mouse (PS/2 type)	KYE SYSTEMS CORP.	N3 Optical	K045205991	DoC

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1.5 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.6 Test Facility

The measurement facility is located at 386-1, Ho-dong, Cheoin-gu, Yongin-si, Gyeonggi-do, 449-100, Korea.

1.7 Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 & 10 meter Open Area Test Sites and one conducted site to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	P -948, C-986
KOREA	MIC	EMI (10 meter Open Area Test Site and two conducted sites) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS PESTING NO. 109 SHO
Europe	GLAS	EMC EN 55011, EN 55022, EN 61000-6-3, EN 61000-6-4, EN 61000-3-2, EN 61000-3-3, EN 61000-6-1, EN 61000-6-2, EN 50130-4, EN 55024, EN 61204-3, EN 60601-1-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-4-11	TÜV No.13000796-02

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2.0 Summary of tests

FCC Part Section(s)	Parameter	Limit	Test Condition	Status (note 1)
15.247(a)	Carrier Frequency Separation	> 25 kHz		С
15.247(a)	Number of Hopping Frequencies	> 75 hops		С
15.247(a)	20 dB Bandwidth	< 1 MHz		С
15.247	Dwell Time	< 0.4 seconds	Conducted	С
15.247(b)	Transmitter Output Power	< 1Watt		С
15.247(d)	Conducted Spurious emission	> 20 dBc		С
15.247(d)	Band Edge	> 20 dBc		С
15.249 /15.209	Field Strength of Harmonics	< 54 dBuV (at 3m)	Radiated	С
15.207 /15.107	AC Conducted Emissions	EN 55022	Line Conducted	С

<u>Note 1</u>: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

Note 2: The data in this test report are traceable to the national or international standards.

The sample was tested according to the following specification:

- FCC Part 15.247, ANSI C63.4-2003

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2.1 Transmitter Requirements

2.1.1 Carrier Frequency Separation

Test Location

RF Test Room

Test Procedures

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function enabled.

After the trace being stable, the reading value between the peaks of the adjacent channels using the marker-delta function was recorded as the measurement results.

The spectrum analyzer is set to:

Span = 3 MHz (wide enough to capture the peaks of two adjacent channels)

RBW = 30 kHz (1% of the span) Sweep = auto

VBW = 30 kHz (RBW) Detector function = peak

Trace = max hold



Figure 1: Measurement setup for the carrier frequency seperation

Limit

The EUT shall have hopping channel carrier frequencies separated minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

Test Results

Carrier Frequency Separation (MHz)	Result
1.020	Complies

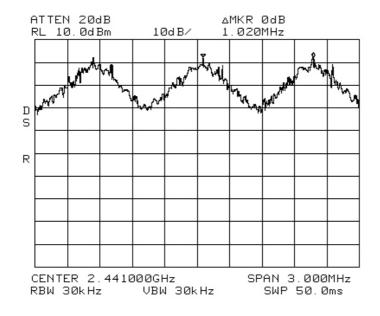
See next pages for actual measured spectrum plots.

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Carrier Frequency Separation



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2.1.2 Number of Hopping Frequencies

Test Location

RF Test Room

Test Procedures

The number of hopping frequencies was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

The spectrum analyzer is set to:

Frequency range 1: Start = 2389.5 MHz, Stop = 2439.5 MHz

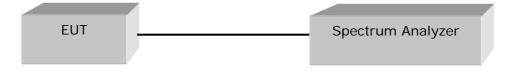
2:Start = 2439.5 MHz, Stop = 2489.5 MHz

Span = 50 MHz

RBW = 300 kHz (1% of the span) Sweep = auto

VBW = 300 kHz (RBW) Detector function = peak

Trace = max hold



Limit

The EUT in the 2400-2483.5 MHz band shall use at least 75 channels.

Test Results

Total number of Hopping Channels	Result
79	Complies

See next pages for actual measured spectrum plots.

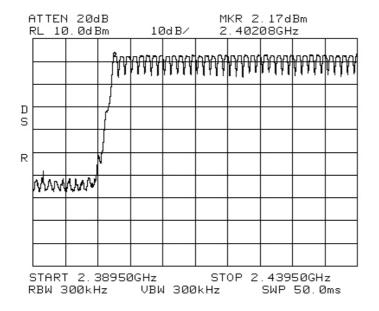
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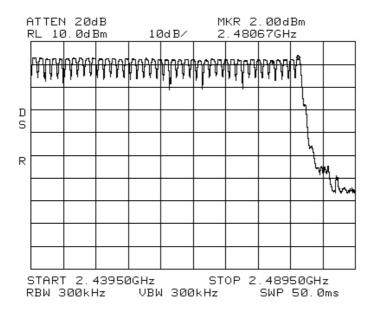


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Number of Hopping Frequencies





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2.1.3 20 dB bandwidth

Test Location

RF Test Room

Test Procedures

The bandwidth at 20 dB below the highest inband spectral density was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function disabled at the highest, middle and the lowest available channels. After the trace being stable, Use the marker-to peak function to set the marker to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is the 20 dB bandwidth of the emission.

The spectrum analyzer is set to:

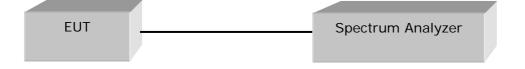
Center frequency = the highest, middle and the lowest channels

Span = 2 MHz (approximately 2 or 3 times of the 20 dB bandwidth)

RBW = 30 kHz (1% of the span) Sweep = auto

VBW = 30 kHz (RBW) Detector function = peak

Trace = max hold



Limit

The Transmitter shall have a maximum 20 dB bandwidth of 1 MHz.

Test Results

Frequency (MHz)	Channel Number.	Measured Bandwidth (MHz)	Result
2441	0	0.860	Complies

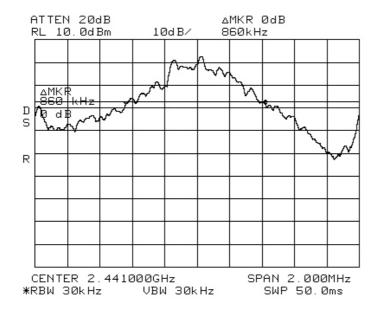
See next pages for actual measured spectrum plots (worst case)

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20 dB Bandwidth



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2.1.4 Time of Occupancy (Dwell Time)

Test Location

RF Test Room

Test Procedures

The dwell time was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function enabled.

The spectrum analyzer is set to:

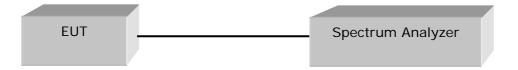
Center frequency = the highest, middle, and the lowest channels

Span = zero

RBW = 1 MHz Trace = max hold

VBW = 1 MHz (RBW) Detector function = peak

Sweep = as necessary to capture the entire dwell time per hopping channel



Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Test Results

Channel	Channel Frequency	Packet Type	Test Re	sults
Number	(MHz)	racket Type	Dwell Time (ms)	Result
		DH 1	135.21	Complies
39	2441	DH 3	272.36	Complies
		DH 5	310.74	Complies

See next pages for actual measured spectrum plots. (Worst case)

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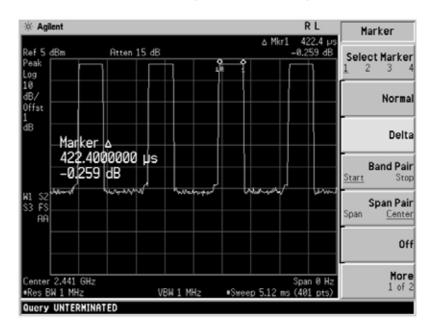
Form No.: CTK-RF-EF-Part15 SubpartC(Rev.2)



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Time of Occupancy for PACKET Type DH 1



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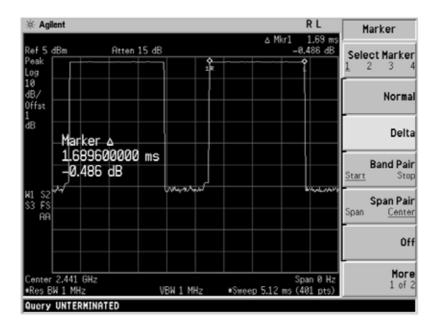
Date: March 16, 2007



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Time of Occupancy for PACKET Type DH 3



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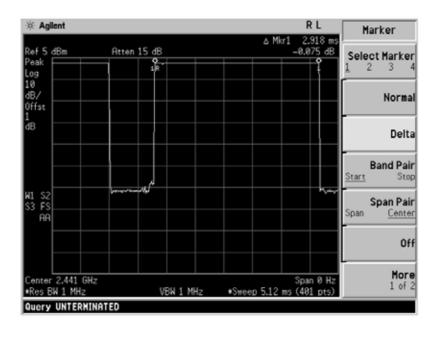
Date: March 16, 2007



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Time of Occupancy for PACKET Type DH 5



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2.1.5 Maximum peak Conducted Output Power

Test Location

RF Test Room

Test Procedures

The maximum peak conducted output power was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function disabled at the highest, middle and the lowest available channels.

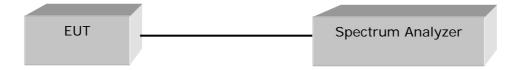
The spectrum analyzer is set to:

Center frequency = the highest, middle, and the lowest channels Span = 5 MHz (approximately 5 times of the 20 dB bandwidth)

RBW = 1 MHz (greater than the 20 dB bandwidth of the emission being measured)

VBW = 1 MHz (RBW) Detector function = peak

Trace = \max hold Sweep = auto



Limit

< 1 W

Test Results

Frequency (MHz)	Channel No.	Peak output power(dBm)	Peak output power(mW)	Result
2402	0	2.67	1.849	Complies
2441	39	2.83	1.919	Complies
2480	78	2.33	1.710	Complies

See next pages for actual measured spectrum plots.

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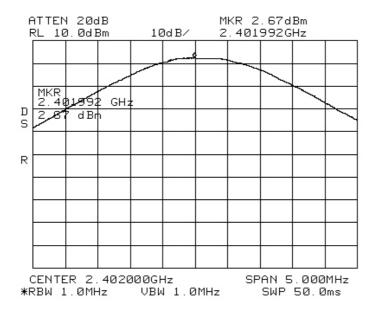
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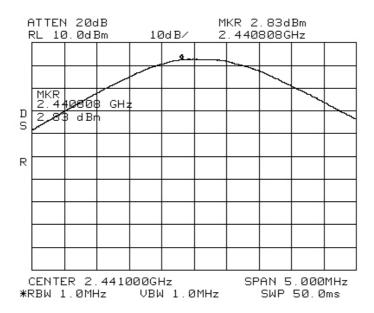
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Maximum peak Conducted Output Power



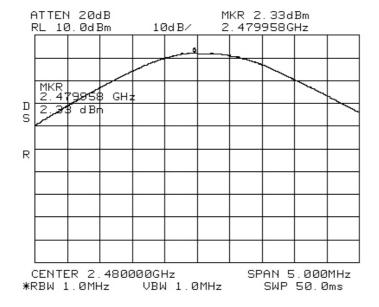


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2.1.6 Band-edge

Test Location

RF Test Room

Test Procedures

The bandwidth at 20 dB down from the highest inband spectral density was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function disabled at the highest, middle and the lowest available channels.

The spectrum analyzer is set to:

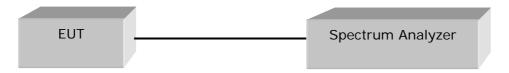
Center frequency = the highest, middle, and the lowest channels

RBW = 100 kHz

VBW = 100 kHz (RBW)

Span = 100 MHz Detector function = peak

Trace = \max hold Sweep = auto



Limit

> 20 dBc

Test Results

All conducted emission in any 100 kHz bandwidth outside of the spectrum band was at least 20 dB lower than the highest inband spectral density.

Therefore the applying equipment meets the requirement.

See next pages for actual measured spectrum plots.

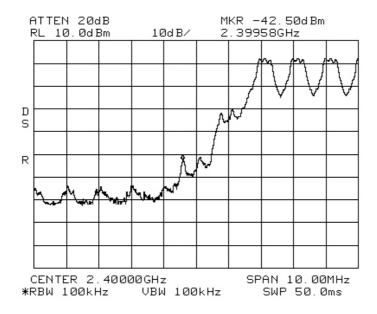
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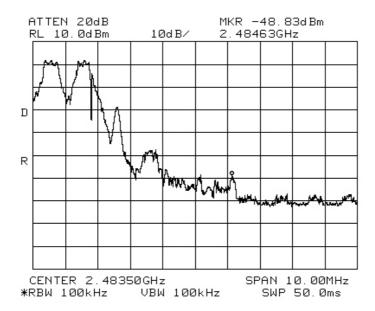
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Band - edge (with Hopping)





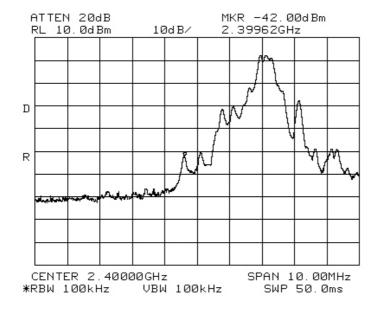
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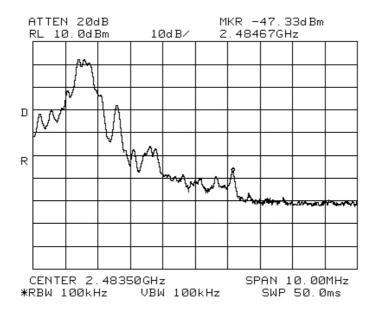
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Band - edge (without Hopping)





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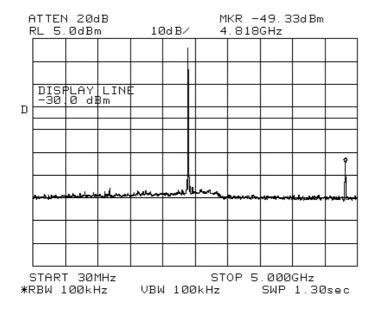
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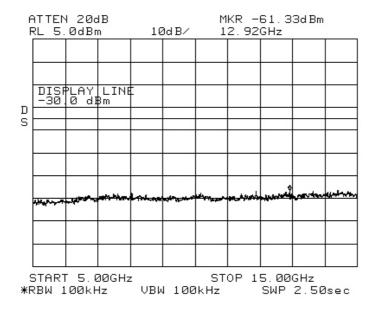


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Band – edge (at 20 dB blow) – Low channel Frequency Range = 30 MHz ~ 10th harmonic





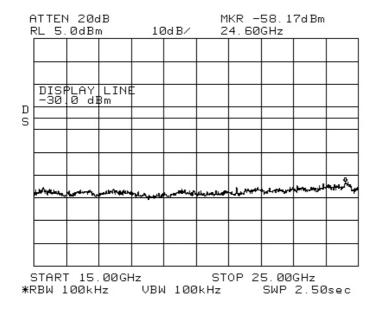
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Band – edge (at 20 dB blow) – Low channel Frequency Range = $30 \text{ MHz} \sim 10^{\text{th}}$ harmonic



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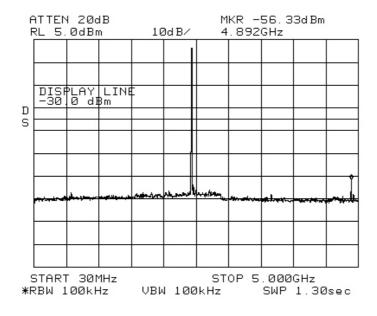
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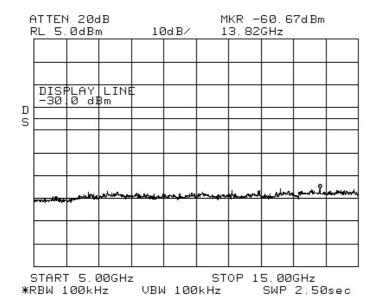


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Band – edge (at 20 dB blow) – Mid channel Frequency Range = 30 MHz ~ 10th harmonic





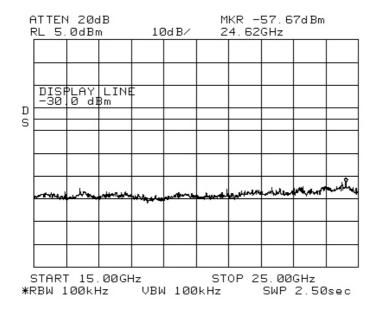
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Band – edge (at 20 dB blow) – Mid channel Frequency Range = 30 MHz $\sim 10^{th}$ harmonic



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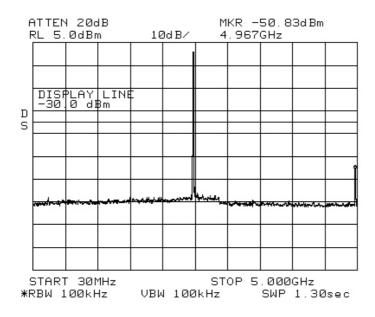
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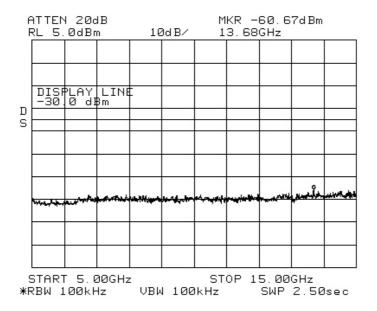


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Band – edge (at 20 dB blow) – High channel Frequency Range = 30 MHz ~ 10th harmonic





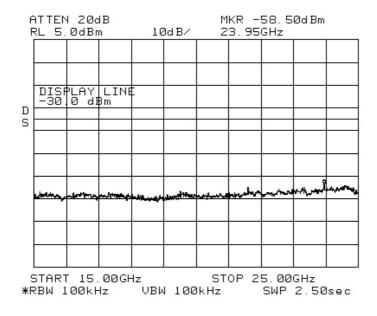
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Band – edge (at 20 dB blow) – High channel Frequency Range = $30 \text{ MHz} \sim 10^{\text{th}}$ harmonic



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2.1.7 Field Strength of Emissions

Test Location

☐ Testing was performed at a test distance of 3 meter Open Area Test Site

Test Procedures

The height of the measuring antenna was varied between 1 to 4 m and the table was rotated a full revolution in order to obtain maximum values of the electric field intensity. The measurement was made in both the vertical and horizontal polarization, and the maximum value is presented in the report.

The spectrum analyzer is set to:

Center frequency = the worst channel

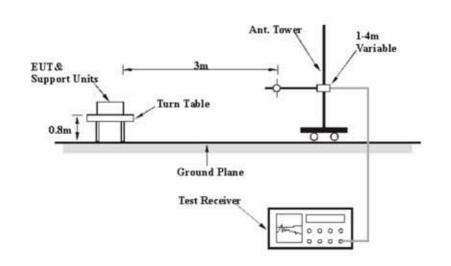
Frequency Range = 30 MHz ~ 10th harmonic

RBW = 120 kHz (30 MHz ~ 1 GHz) VBW RBW

= 1 MHz (1 GHz ~ 10th harmonic)

Span = 100 MHz Detector function = Quasi-peak

Trace = max hold



Limit

- 15.209(a)

	: 0: 20 ; (2)		
Frequency(MHz) Field Strength u\		Field Strength uV/m@3m	Field Strength dBuV/m@3m
ĺ	30-88	100**	40
ĺ	88-216	150**	43.5
ĺ	216-960	200**	46
ĺ	Above 960	500	54

^{**} Except as provided in 15.209(g).fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54-72MHz, 76-88MHz, 174-216MHz, 470-806MHz. However, operation within these frequency bands is permitted under other sections of this Part, e.g.15.231 and 15.241.

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Test Results

EUT	Thermal mobile printer	Measurement Detail	
Model	SPP-R200	Frequency Range	Below 1000MHz
Channel	Channel 0	Detector function	Quasi-Peak

The requirements are:

□ Complies

Frequency	Measured Data	Margin	Remark
(MHz)	(dBuV/m)	(dB)	
864.10	37.5	8.5	Quasi-Peak

Test Data

Frequency	Reading	Pol.	Height	Correction Factor		Limits	Result	Margin	
[MHz]	[dBuV/m]		[m]	Antenna	Amp. Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]
556.25	15.0	Н	1.0	16.4		3.8	46.0	35.2	10.8
592.61	15.1	Н	4.0	16.9		4.0	46.0	36.0	10.0
636.15	13.6	Н	4.0	17.7		4.1	46.0	35.4	10.6
805.16	10.8	V	1.8	19.8		4.9	46.0	35.5	10.6
847.00	11.4	V	2.0	20.2		4.9	46.0	36.5	9.5
864.10	12.1	V	2.0	20.5		4.9	46.0	37.5	8.5

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Test Results

EUT	Thermal mobile printer	Measurement Detail		
Model	SPP-R200	Frequency Range	1-25GHz	
Channel	Channel 0	Detector function	Peak	

The requirements are:

Frequency	Measured Data	Margin	Remark
(MHz)	(dBuV/m)	(dB)	
2483.62	42.9	11.1	Peak

Test Data

Frequency	Reading	Pol.	Height	Correction Factor			Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Amp. Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]
1880.60	43.4	V	1.0	25.4	35.6	6.6	54.0	39.8	14.2
2376.50	40.8	V	1.0	28.2	35.3	7.4	54.0	41.1	12.9
4804.20	31.0	V	1.0	32.7	34.9	11.4	54.0	40.2	13.8
7370.10	24.9	V	1.0	37.7	34.8	14.3	54.0	42.1	11.9
9610.40	19.9	V	1.1	38.4	35.4	16.9	54.0	39.8	14.2

^{*} No emissions were detected at a level greater than 10dB below limit

Restricted band edge test data

Measured frequency range: 2310-2390 MHz, 2483.5-2500 MHz

Frequency	Reading	Pol.	Height		Correction Factor		Limits	Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Amp. Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]
2376.80	39.5	V	1.0	28.2	35.3	7.4	54.0	39.8	14.2
2483.62	42.6	V	1.0	28.2	35.3	7.4	54.0	42.9	11.1

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2.1.8 AC Conducted Emissions

Test Location

Shielded Room

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Procedures

The EUT was placed on a non-metallic table 0.8m above the metallic, grounded floor and 0.4m from the reference ground plane wall. The distance to other metallic surfaces was at least 0.8m.

Amplitude measurements were performed with a quasi-peak detector and an average detector.

Limit

- 15.207(a)

Frequency	Conducted Limit (dBuV)				
(MHz)	Quasi-peak	Average			
0.15 ~ 0.5	66 to 56*	56 to 46*			
0.5 ~ 5	56	46			
5 ~ 30	60	50			

^{*} Decreases with the logarithm of the frequency.

Test Results

The requirements are:

□ Complies

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
0.20	37.9	15.7	Average

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Test Data

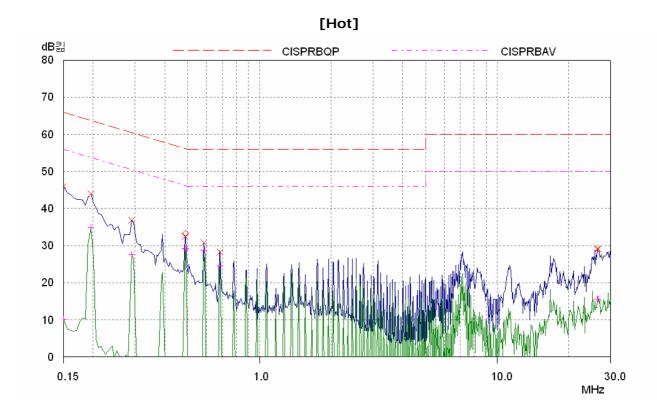
Frequency	Correction				Quasi	-peak			Ave	rage	
1,111	Fac	tor	Line	Limit	Reading		Margin	Limit	Reading		Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.15	0.1	0.2	Н	66.0	45.7	46.0	20.0	56.0	9.8	10.1	45.9
0.20	0.1	0.2	N	63.6	44.0	44.3	19.3	53.6	37.6	37.9	15.7
0.29	0.1	0.2	N	60.5	38.0	38.3	22.2	50.5	30.7	31.0	19.5
0.49	0.1	0.2	N	56.2	32.5	32.8	23.4	46.2	24.0	24.3	21.9
0.59	0.1	0.2	N	56.0	35.2	35.5	20.5	46.0	26.3	26.6	19.4
0.69	0.1	0.2	Н	56.0	27.9	28.2	27.8	46.0	24.3	24.6	21.4

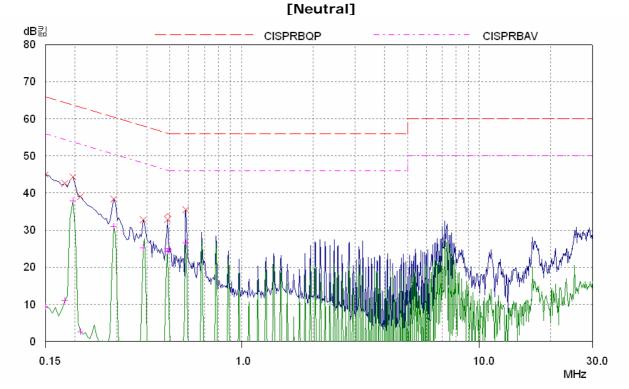
H: HOT, N: NEUTRAL

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APPENDIX A – Test Equipment Used For Tests

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
1	Spectrum Analyzer	Agilent	8564E	3551A0041	2007-11-03
2	EMI Test Receiver	Rohde & Schwarz	ESVS30	826638/008	2007-04-25
3	ULTRA Broadband Antenna	Rohde & Schwarz	HL562	361324/014	2007-06-12
4	Biconical Antenna	EMCO	3110	9202-1510	2007-04-25
5	Log-periodic Antenna	EMCO	3146	9607-4567	2007-04-25
6	Field Strength Meter	Rohde & Schwarz	ESHS30	828144/002	2008-02-15
7	LISN	EMCO	3825/2	9607-2575	2007-09-01
8	LISN	EMCO	3825/2	9409-2246	2007-09-01
9	Field Strength Meter	Rohde & Schwarz	ESHS30	862024/001	2008-03-07
10	System Power Supply	HP	6032A	3440A-10521	2007-07-06
11	EPM Series Power Meter	HP	E4418A	GB38272734	2007-11-03
12	Power Sensor	HP	8481A	331BA92056	2007-11-01
13	Power Sensor	HP	8482B	331BA05406	2007-10-27
14	Audio Analyzer	HP	8903B	2747A03432	2007-11-03
15	ESG-D Series Signal Generator	Agilent	E4432B	US40054094	2007-11-03
16	Modulation Analyzer	HP	8901B	3438A05228	2007-11-06
17	Attenuator	HP	8494A	3308A33351	2007-10-27
18	Attenuator	HP	8496A	3308A15142	2007-10-27
19	Temp&Humi Chamber	Kunpoong	KP-1000	2002KP050041	2008-01-15
20	EMC Analyzer	Agilent	E7403A	MY42000054	2007-10-18
22	Horn Antenna	ETS-Lindgren	3115	00078894	2008-11-29
23	Horn Antenna	ETS-Lindgren	3116	00062504	2008-11-27
24	OPT H64 AMPLIFIER	HP	8447F	3113A06814	2008-03-03
25	PREAMPLIFIER	Agilent	8449B	3008A02307	2007-11-20

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